

ID	R _{DS} (ON)(Typ)	VDSS
150A	3.0mΩ	30V
• 100% a	: vitching speed avalanche tested ved dv/dt capability	

Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS30N150T	T0-220	RS30N150T	Tube	50 PCS

Absolute Maximun Ratings Tc= 25° unless otherwise specified

Symbol	Parameter	RS30N150T	Units
VDSS	Drain-to-Source Voltage	30	V
ID	Continuous Drain Current TC=25℃	150	
ID	Continuous Drain Current TC=100 $^\circ\!\!\mathbb{C}$	100	А
IDM	Pulsed Drain Current	500	
PD	Power Dissipation	120	W
VGS	Gate- to- Source Voltage	±20	V
EAS	Single Pulse Avalanche Engergy L = 0.5mH,VDD = 55V, RG = 25Ω, Tj = 25℃	350	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS30N150T	Units	Test Conditions
RØJC	Junction-to-Case	1.04	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^\circ\!\!C$
RθJA	Junction-to- Ambient	20		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25° C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	30			V	VGS=0V,ID=250μ Α
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=30V,VGS=0 V
	Gate- to- Source Forward Leakage			100	^	VGS=20V ,VDS=0 V
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-20V ,VDS= 0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On-		3.0	4.0	mΩ	VGS=10V,ID=30A
	Resistance		4.0	6.0	mΩ	VGS=4.5V,ID=20 A
VGS(TH)	Gate Threshold Voltage	1.0		2.0	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		11			
trise	Rise Time		10			VDS=20V
td(OFF)	Turn- OFF Delay Time		35		nS	ID=20A RG=3Ω VGS=10V
tfall	Fall Time		9			



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		4000			VGS= 0V
Coss	Output Capacitance		450		pF	VDS=25V
Crss	Reverse Transfer Capacitance		430			f=1.0MHz
Qg	Total Gate Charge		75			VDS= 15V
Qgs	Gate- to- Source Charge		9		nC	ID=20A VGS=10V
Qgd	Gate-to-Drain(" Miller") Charge		18			

Source- Drain Diode Characteristics

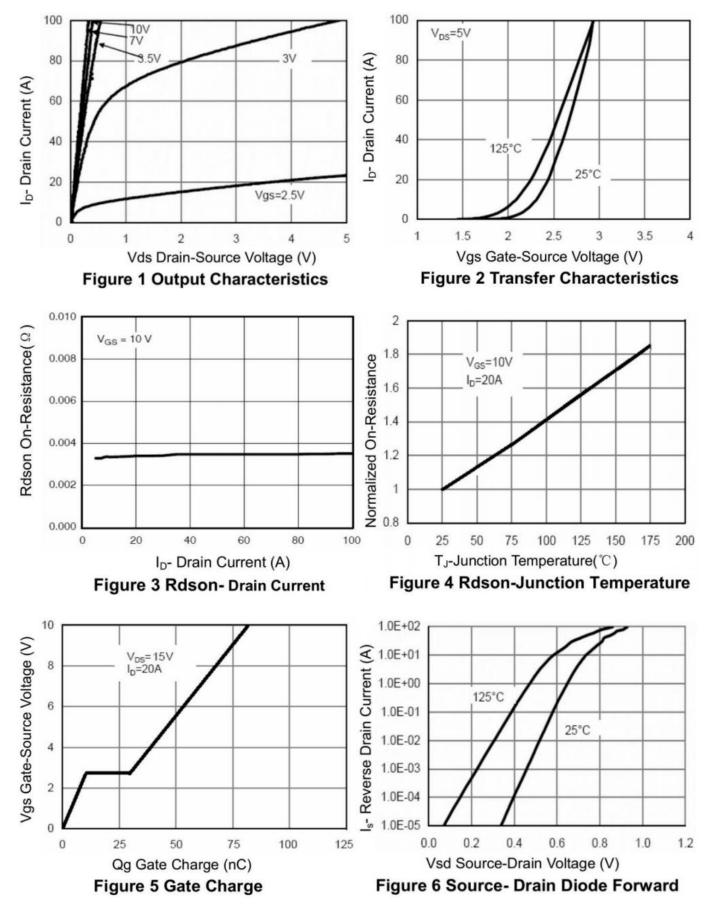
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
IS	Continuous Source Current			150	А	Integral pn- diode	
ISM	Maximum Pulsed Current			500	А	in MOSFET	
VSD	Diode Forward Voltage			1.2	V	IS=20A,VGS=0V	
trr	Reverse Recovery Time		26		nS	VGS=0V	
Qrr	Reverse Recovery Charge		34		nC	IS=20A di/dt=100A/μs	

Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1%

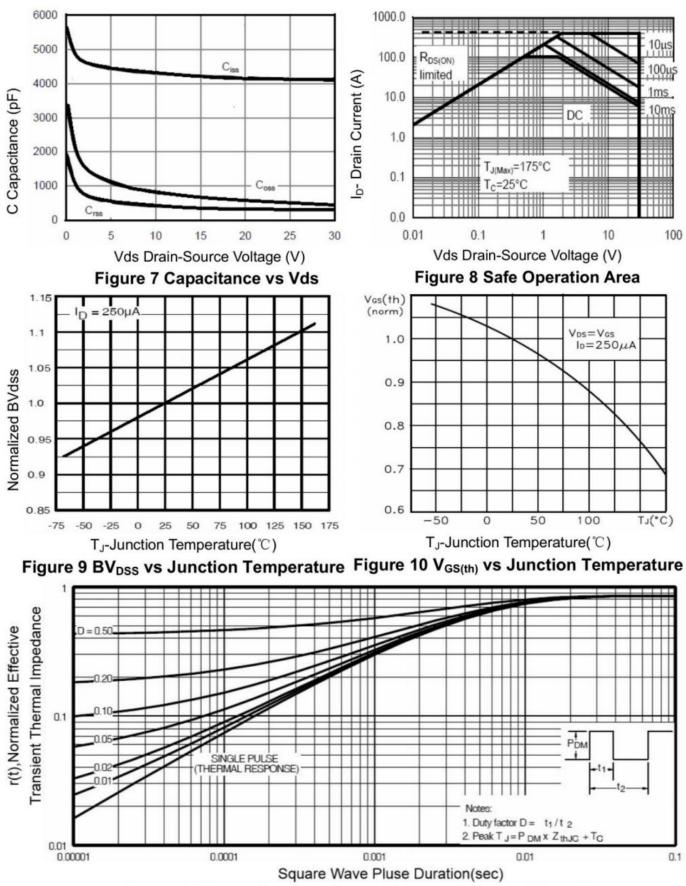


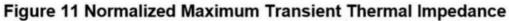
Typical Feature Curve



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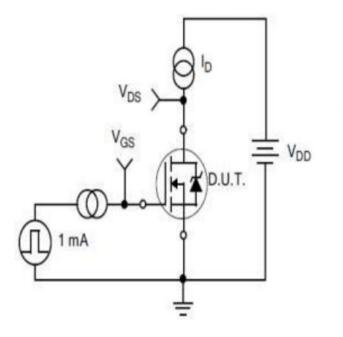








Test ircuits and Waveforms



VGS(TH)

VDS

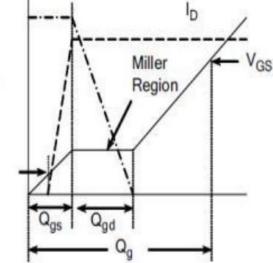


Figure A. Gate Charge Test Circuit

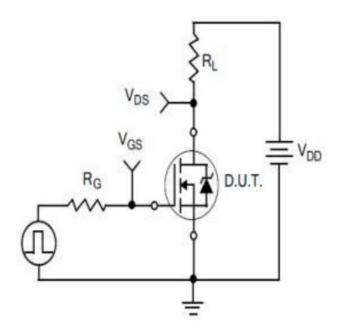


Figure C. Resistive Switching Test Circuit

Figure B. Gate Charge Waveform

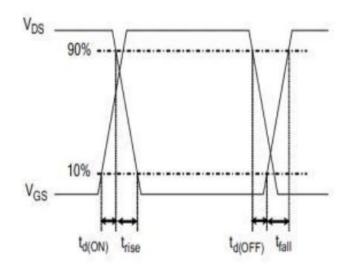
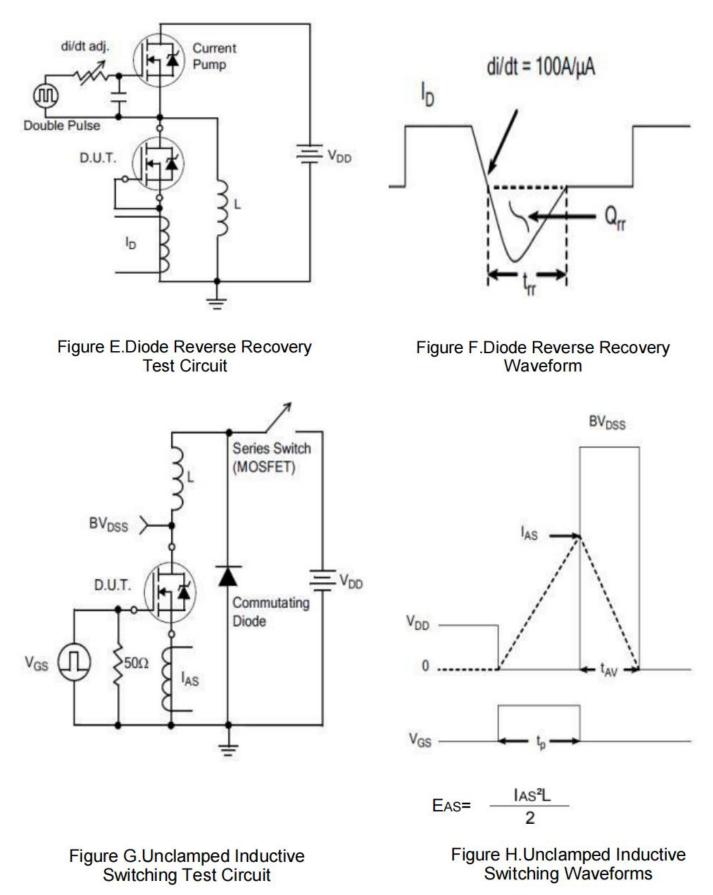


Figure D. Resistive Switching Waveforms

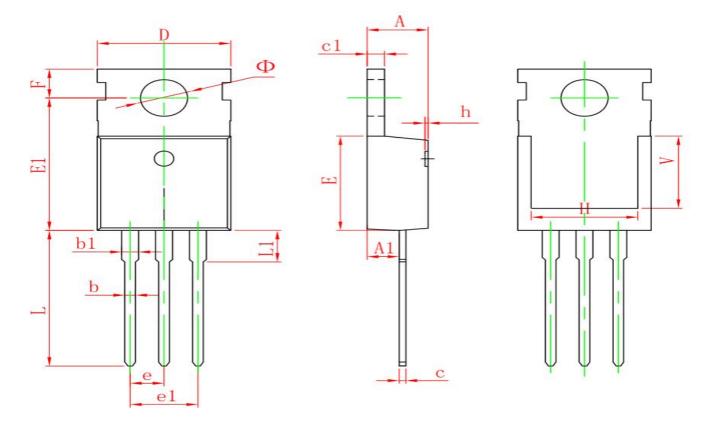


Test ircuits and Waveforms





Package outline drawing(TO-220 Unit: mm)



Symbol	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
A	4.400	4.600	0.173	0.181
A1	2.250	2.550	0.089	0.100
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
С	0.330	0.650	0.013	0.026
c1	1.200	1.400	0.047	0.055
D	9.910	10.250	0.390	0.404
E	8.950	9.750	0.352	0.384
E1	12.650	13.050	0.498	0.514
е	2.540	TYP.	0.100) TYP.
e1	4.980	5.180	0.196	0.204
F	2.650	2.950	0.104	0.116
Н	7.900	8.100	0.311	0.319
h	0.000	0.300	0.000	0.012
L	12.900	13.400	0.508	0.528
L1	2.850	3.250	0.112	0.128
V	6.900	6.900 REF.		REF.
Ф	3.400	3.800	0.134	0.150



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